



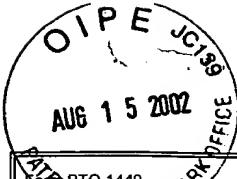
SHEET 1 OF 1

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 201989US3	SERIAL NO. 09/760,786		
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Hirokazu SAKAI, et al.					
		FILING DATE January 17, 2001		GROUP 3764			
<b>U.S. PATENT DOCUMENTS</b>							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
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	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						
<b>FOREIGN PATENT DOCUMENTS</b>							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO	
KA	AO	10-248634	09/22/98	JAPAN (with English Abstract)		X	
	AP						
	AQ						
	AR						
	AS						
	AT						
	AU						
	AV						
<b>OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)</b>							
	AW						
	AX	<b>RECEIVED</b>					
	AY	MAY 16 2001					
	AZ	TECHNOLOGY CENTER R3700					
Examiner <i>1000</i>					Date Considered <i>1/28/02</i>		

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 201989US3		SERIAL NO. 09/760,786	
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT		Hirokazu SAKAI, et al.		1037648 JAN 17 2002 RECEIVED MAIL ROOM	
		FILING DATE		January 17, 2001		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	TRADEMARK OFFICE DATE	NAME		CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
RAK	AA 4,533,273	08/06/85	Saburo OBATA, et al.				1037648 JAN 17 2002
AB							
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FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY		TRANSLATION YES      NO		
AO							
AP							
AQ							
AR							
AS							
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AU							
AV							
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						
Examiner <i>RAK</i>				Date Considered <i>1/25/02</i>			

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE  LIST OF REFERENCES CITED BY APPLICANT		ATTY DOCKET NO. 201989US3	SERIAL NO. 09/760,786		
		APPLICANT Hirokazu SAKAI, et al.			
		FILING DATE January 17, 2001	GROUP 3764		
U.S. PATENT DOCUMENTS					
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS SUB CLASS FILING DATE IF APPROPRIATE
AA					
AB					
AC					
AD					
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AL					
AM					
AN					
FOREIGN PATENT DOCUMENTS					
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES      NO
AO	AO	0 096 102 A1	12/21/83	EP (German)	
AP	AP	2 174 356 A	11/05/86	Great Britain	
AQ	AQ	345431	05/13/60	Switzerland	
AR					
AS					
AT					
AU					
AV					
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)					
	AW				
	AX				
	AY				
	AZ				<input type="checkbox"/> Additional References sheet(s) attached
Examiner	D. DeMille			Date Considered 1/16/03	

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.